

PRODUCTION OF ELECTROLYTIC CAPACITORS AND SUPERCONDUCTORS

This application claims priority from U.S. Provisional Application Serial No. 60/434,039, filed December 17, 2002, and is a continuation-in-part of co-pending application Serial No. 10/282,354, filed October 29, 2002, which is in turn a continuation-in-part of co-pending application Serial No. 10/037,935, filed January 2, 2002, which is in turn a continuation-in-part of Serial No. 09/753,200, filed January 2, 2001, now abandoned, which is in turn a continuation-in-part of U.S. Application Serial No. 09/532,362, filed March 21, 2000, now U.S. Patent 6,543,123 issued April 8, 2003. The subject matter of all of these parent applications is incorporated herein by reference.

BACKGROUND OF THE INVENTION

The present invention is directed to the production of electrical devices, e.g. electrolytic capacitors and superconducting materials based on the use of valve metals such as tantalum and niobium and its alloys. In work done previously by the assignee of this patent application there have been described developments wherein filaments of refractory metals such as tantalum and niobium are extruded in a softer metal such a copper while encased in a surrounding sleeve of the valve metal e.g. tantalum or niobium. Utilizing this technology filaments of either tantalum or niobium have been drawn to very small diameters while in the copper matrix and while surrounded by the constraining layer of tantalum or niobium. The copper is leached out from between the very fine filaments in the final product while the fine filaments are constrained in a manageable bundle by the outer constraining acid resistant layer of tantalum or niobium. This technology is more fully described in our prior parent U.S. patent number 5,869,196 and our PCT Application Serial No. PCT/US03/24724, filed August 7, 2003.

1 In the present invention there is an improvement over the processed described in the '196
2 patent above wherein the constrained mass of small fine tantalum or niobium filaments is
3 subjected to a rolling deformation which flattens the individual small filaments so that each wire
4 has aspect ratio of at least 5:1. This relatively high aspect ratio in the final compressed and
5 flattened individual fine filaments has the following major advantages. When the Nb is reacted
6 to form Nb₃Sn, currently, round Nb filaments require in excess of 180 hours at 700°C to
7 completely react 4-micron filaments. The same filament rolled to an aspect ratio of 5:1 will be
8 only 1.26μ thick by 12.6μ wide and can be fully reacted using considerably shorter times. By
9 reducing the time and distance for reaction, finer grain size and more importantly, uniform
10 Nb₃Sn are obtained and as a result, higher current densities as well.

11 A flat conductor is easier to wind into a magnet and it has higher filling factor where the
12 void space when a round conductor is used is eliminated. Another important consideration is
13 that thin conductors are more ductile and can be wound into magnets of small diameters. A
14 reacted Nb₃Sn; flattened to an aspect ratio of 5:1, with a thickness of 0.02mm thickness by
15 0.02mm wide can be bent around a radius of 5cm without fracturing the wire. This offers the
16 possibility of reaction and winding, similar to present day ductile NbTi magnets.

17 An unexpected discovery has been that the improvements for superconductor have been
18 shown to be even more important for capacitors. The filament size, its number, spacing and
19 surface area/unit volume are exactly the same critical designs parameters for both applications.
20 In the case for superconductors, the entire Nb filament is converted to superconducting Nb₃Sn.
21 For capacitors, the surface of the Nb filament is converted to Nb₂O₅, the dielectric compound for
22 capacitors use. In fact, with only minor size and shape adjustment, the wire can be used as
23 either a superconductor or as an anode for solid Nb electrolytic capacitors. Confirmation of the

dual use possibility of this invention are further demonstrated by two recent publications, Alternative Materials for Electrolytic Capacitors by Dr. K. Reichert, T. I. C. Bulletin, No. 109 March 2002 page 2-3, and Powder for Capacitor, Sintered Body Thereof and Capacitor Using the Sinter Body PCT/JP01/10484 OMORI, Kazuhiro, 6 June 2002, where Ta and Zr alloys of Nb, used for superconductors, has been shown to have excellent capacitor properties as well.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig. 1 is a schematic depiction of the primary billet used in the preferred embodiment of the present invention. Fig. 1a shows a transverse cross section. Fig. 1b is a cutaway view revealing the longitudinal disposition of the billet components.

Fig. 2 is a flow-chart describing the steps followed in the execution of the process used in the preferred embodiment of the invention, along with steps that may be employed in other embodiments.

Fig. 3 is a schematic depiction of the transverse cross section of the secondary billet used in the process of the present invention. Fig. 3a shows the billet in the preferred embodiment of the present invention, wherein the sheath is circumferentially continuous. Fig. 3b shows the billet in another embodiment, wherein the sheath contains a gap that renders it circumferentially discontinuous, but overlapping. Fig. 3c is similar to Fig. 3b in that the sheath is shown as being circumferentially discontinuous, but no overlap is present.

Fig. 4 is a schematic depiction of the product of the preferred embodiment of the present invention. Fig. 4a shows the product as a cylindrical body. Fig. 4b shows the product after shaping into a rectangular body.

Fig. 5 schematically illustrates another embodiment of the present invention. Fig. 5a shows the transverse cross section of the secondary billet used in this embodiment of the present

invention. Fig. 5b shows the product of this embodiment as a cylindrical body with a thin, metallurgically bonded tab of tantalum or niobium.

DETAILED DESCRIPTION OF THE INVENTION

In the preferred embodiment of the present invention for making capacitor anodes, the process begins with niobium or tantalum rods that are inserted into holes drilled longitudinally into a copper billet, shown schematically in Figs. 1a and 1b. Referring to the Figures, the copper forms a matrix 1 which separates the tantalum or niobium rods 2. The assembly as a whole forms the primary billet 3. As Fig. 1b indicates, the rods run longitudinally through the body of the billet and are substantially parallel. After assembly, a copper nose and tail are welded onto the primary billet, and the billet is then evacuated and sealed. At this point the primary billet may optionally be hot or cold isostatically pressed (HIP'd or CIP'd) in order to collapse any void space, thereby promoting filament uniformity. If the billet is hot or cold isostatically pressed, it will usually be machined on a lathe afterwards in order to restore a cylindrical shape.

The primary billet, containing the niobium or tantalum rods in a copper matrix, is processed in accordance with the flow-chart of Fig. 2. The billet is extruded at elevated temperature at a diameter reduction ratio of approximately 6:1. The resulting rod is cropped, and the rod is drawn down to restack diameter. As indicated in Fig. 2, annealing may optionally be performed during drawing should the wire become too stiff or breakage occurs. Annealing temperatures for tantalum and niobium are well known in the art they are typically in the range of 900°C.

At restack diameter, the composite wire is cut into lengths for assembly into the secondary billet. The secondary billet transverse cross section is shown schematically in Fig.

3a. The subelements 4 made from the primary billet are stacked together with copper rods. The copper rods are used to form a copper core 5, and an outer annulus 6. Both the core and the outer annulus are provided in order to make leaching of the final composite less difficult. Outside the assembly of the subelements and copper rods is a layer of tantalum sheet 7. The sheet is the same length as are the rods and it completely surrounds the filament array. The sheet thickness is comparable to the diameter of the niobium or tantalum filaments within the subelements. Outside the cylinder of niobium or tantalum sheet is an outer copper can 8.

The secondary billet is assembled, a nose and tail are welded into place, and the billet is evacuated and sealed. The sealed billet is optionally prepared for extrusion by hot or cold isostatic pressing in order to collapse any void space within the billet and to promote filament uniformity. After isostatic pressing, the secondary billet is machined to fit the extrusion liner. The billet is then extruded at elevated temperature at a diameter reduction ratio of 6:1.

The extruded rod is cropped, and the rod is then drawn to a diameter where the niobium or tantalum filament diameter is 5 microns or less. Again, as indicated in Fig. 2, annealing steps may be employed if necessary. At final size, the composite wires is cut into short lengths as required, preferably not less than 1.5 times the final wire diameter. The cutting process must be as "clean" as possible, by which is meant that smearing or pinching at the ends of the cut sections must be kept to a minimum. If the cutting does not provide sufficiently clean ends, this will interfere with the subsequent leaching process. Clean cut ends may be achieved through the use of a high-precision impact cutoff machine.

The cut sections are immersed in a solution of nitric acid and water. A suitable solution would be one part nitric acid to one part water, but other concentrations of nitric acid can be employed if required. The sections are immersed for a period of time sufficient for the acid to

1 fully leach out the filaments and the sheath. The total time will depend primarily upon the
2 composite wire diameter and length, with smaller diameters and greater lengths requiring longer
3 times. This is due to the fact that the acid can only penetrate through the ends of the cut sections.
4 Narrow openings and long distances do not lend themselves to rapid etching.

5 In regard to the leaching process, it is an essential feature of this embodiment of the
6 present invention that the secondary billet is provided with a copper core 5 and a copper annulus
7 6 (Fig. 3a). During the leaching process, the copper core and annulus etch away much more
8 rapidly than does the copper separating the filaments, since the filaments are comparatively
9 tightly spaced. As a result, the acid eventually surrounds the annulus of filaments, and can then
10 attach the filament matrix from all directions, rather than just from the ends of the cut sections.
11 The design of the secondary billet thus greatly improves the efficiency of the leaching process.

12 After leaching, one is left with the product of the present invention, shown schematically
13 in Fig. 4a. It consists of fine filaments (<5 micron diameter) 9, surrounded by a thin tube 10.
14 This product can be made into an anode for an electrolytic capacitor by conventional means,
15 including sintering, anodizing, infiltrating with electrolyte, etc. It may be desirable to shape the
16 product of the present invention by means such as pressing in a die. A rectangular chip can be
17 produced in this manner. Such a chip is illustrated in Fig. 4b. A rectangular chip may be more
18 compatible with current industry standards. The shaping is preferably performed prior to
19 sintering of the product. The shaping may be done either with or without the ductile metal
20 matrix present (see Fig. 2). In addition to shaping, it may be desirable to further compact the
21 product of the present invention. In such cases, the product is compressed, rather than simply
22 reshaped. Further compaction may be beneficial to electrical continuity with the compact.

1 Depending upon the degree of electrical continuity and the level of purity within the
2 product of the present invention, it may not be necessary to sinter the product. If sintering is
3 avoided, the process of the present invention will be less expensive. The decision on whether or
4 not to sinter the product will depend primarily upon the requirements of the application.

5 Another embodiment of the invention employs the secondary billet illustrated
6 schematically in Fig. 3b. The billet is identical to that shown in Fig. 3a except that the layer of
7 niobium or tantalum sheet 7 is not circumferentially continuous, but contains a gap 11. The gap
8 is positioned at an overlap in the sheet, so that the filaments are completely surrounded by the
9 niobium or tantalum layer, much as in the preferred embodiment. A section of copper sheet is
10 inserted into the gap so as to prevent niobium or tantalum-to-niobium or tantalum contact in the
11 region of the overlap. Processing of the secondary billet proceeds exactly as described above,
12 including leaching in nitric acid. The gap in the sheath accelerates the leaching process, since
13 the acid can now penetrate from the exterior of the cut sections, as well as from the ends.

14 Yet another embodiment of the invention employs the secondary billet illustrated
15 schematically in Fig. 3c. This embodiment is similar to that illustrated in Fig. 3b, and described
16 above, except that the sheet 7 does not overlap. The sheet does not fully surround the filaments,
17 leaving the gap 11. Although the sheet does not fully surround the filaments, it does to a
18 substantial extent, so that the filaments are for the most part constrained. Processing of the
19 secondary billet proceeds as described above. Again, the gap in the sheath serves to accelerate
20 the leaching process.

21 Yet another embodiment of the present invention employs the secondary billet illustrated
22 schematically in Fig. 5a. The secondary billet is similar to that illustrated in Fig. 3b, except that
23 the copper sheet is circumferentially continuous. Referring to Fig. 5a, the copper sheet 7 fully

1 encloses the array of filaments in their copper matrix, and then continues for some distance to
2 create the overlap 18. The overlap is separated from the bulk of the sheath by a section of
3 copper sheet that is inserted into the gap 11. The secondary billet is processed as in the preferred
4 embodiment of the invention. After the final leaching step, one is left with a number of small
5 bodies like that illustrated schematically in Fig. 5b. The filaments 9 are constrained within the
6 sheath 10. The overlapping sheet 18 of the secondary billet forms a thin tab that is
7 metallurgically bonded to the sheath as a result of secondary billet processing. A lead wire may
8 be attached to the tantalum tab or the tab itself may be used as a lead wire during anodization
9 and impregnation of the capacitor. The tab may also serve as an electrical contact in final
10 capacitor packaging.

11 In other embodiments of the invention, all or part of the sheath is made to be perforated
12 or porous so as to accelerate the leaching process while still maintaining the effectiveness of the
13 sheath with regard to constraint of the enclosed filaments.

14 Patent '196, specifically describes the inclusion of a separate outer sheath of Tantalum or
15 Niobium to further constrain the filament bundle. A major advantage of both processes is
16 illustrated in Figs. 4a and 4b of patent '196, where examples of finished shaped anodes are
17 shown and thus eliminates completely the need to handle and press fine powders.

18 The ability to shape the anode to almost any shape or form provides the basis for
19 capacitor application. The papers as listed below are relevant to this application.

- 20 1. D.A. McLean, The AC Properties of Tantalum Solid Electrolytic Capacitors,
21 journal of the Electro chemical Society January 1961 page 48-56.
- 22 2. P.L. Bourgault and J. Batlaan, Low ESR Solid Tantalum Capacitors;
23 Proceeding Electronic Component Conference 1968, page 38-43.

1 3. S. Hluchan, Powder Geometry and Structural Design of the High Volumetric
2 Efficiency Tantalum Electrolytic Capacitor: IEEE Transaction on Parts,
3 Hybrids, and Packaging, Volume PHP-9, No. 3, September 1973, page 148-
4 155.

5 McLean shows that the A.C. properties of porous tantalum solid electrolytic capacitors
6 are frequency dependent and that the capacitance decreases and internal resistance or ESR
7 increases with increasing frequency. Theoretically, an ideal capacitor would operate with
8 essentially zero ESR. As the ESR increases, heat is generated, possibly leading to capacitor
9 failure, and electrical circuit problems. In Bourgault's equation 9, the dissipation factor or ESR
10 is proportioned to the square of the radius of the capacitor. In other words, the efficiency of the
11 capacitor is size dependent. He concluded that a thin wall anode or hollow tube was the desired
12 shape and as a result, U.S. Patent 3,345,545 was issued. The concept of an ideal anode shape to
13 improve capacitors performance was also confirmed in the paper by Hluchan. An ideal anode
14 would be one where the thickness is that of a foil, somewhere about 25 to 100 microns and a
15 width of approximately 2-10 mm wide. The foil should be porous, and contain a high specific
16 surface area/volume. Most importantly it must be robust and capable of being physically
17 handled when subjected to the processing step necessary to produce a finished capacitors. It has
18 been found in our experiments that the chip anode shape of Fig. 4b of my patent '196 can in fact
19 produce the desired foil and is illustrated by Table 1. In table 1, 0.020" and 0.030" round wires,
20 made according to our patent '857 and '196, were rolled to the indicated thin ribbon dimensions.
21 Billet 33B/30A contains 9/125 filaments and measures 12 μ and 18 μ in diameter at the 0.020"
22 and 0.030" sizes prior to rolling. As the rolling reduction is increased, the width also
23 substantially increases. Aspect ratio of greater than 40:1 has been obtained. The optimum

aspect ratio would generally favor the thinnest foil. Other factors can, however influence the degree of reduction. For example, as the filaments are flattened, they are also closer together and copper removal can become difficult. If the filaments are too thin, then, they can possibly lose capacitance, since they can be totally consumed during the anodization step.

TABLE 1

Sample	Size & Shape	Size/Shape
33B/30A	0.020" round	0.030" round
33B/30A	0.010 x 0.030"	
33B/30A	0.006 x 0.047"	0.00285" x .125"
33B/30A	0.004 x 0.079 foil	

Metallagraphic studies of the cross-section show that the decreasing thickness, the filament are also flatten and its aspect ratio increases to as much as 10:1, measuring approximately $2\mu \times 20\mu$ wide. It is obvious that the rolling process has increased the available surface area of the filaments significantly and at the same time provide the ideal shape for AC application.

Handling of these highly aspected thin foil can be more difficult after leaching. Some structural support appears to be necessary. This can be accomplished by a simple change in billet design. In place of a uniform array of rods as shown in Fig. 1a, a single large diameter rod is inserted into the center of the billet. This billet, when finally rolled to the desired thickness and with will form a continuous inner foil exactly at the center of the larger foil, surrounded by the outer filaments. It now supports the filaments, provides a common electrical contact, and

1 acts as a convenient location for the anode termination. The central rod should not exceed 20%
2 by area of Cu and can be adjusted as required.

3 Copper removal is more difficult for these highly compacted foils. The flattened
4 filaments are extremely close together and may even be touching. To insure complete copper
5 removal, a continuous liquid magnesium dipping process can be used to leaching the copper
6 from the foil. Copper is completely soluble in liquid magnesium while Ta and Nb are insoluble.
7 A similar process, used to leach the copper matrix with liquid Sn was shown in our aforesaid
8 U.S. patent application Serial No. 09/532,362. The magnesium matrix can then be easily
9 removed by a combination of vacuum distillation and an acid clean step.

10 To increase the total capacitance of this foil shape, several foils can be arranged much
11 like that of the MLCC (Multi-Layer Ceramic Capacitor) where layer are stacked together and
12 electrically connected in parallel. This concept is also shown in paper by J. Gerblinger, given at
13 the Symposium on Tantalum and Niobium, San Francisco held October 22, 2002 titled Tantalum
14 Capacitors Today and Tomorrow, pages 329-342. See, in particular, figures 3 and, in which
15 Multi-Anode capacitors designs are shown and are cited as a solution for obtaining minimum
16 ESR performance.